2. Link and Memory Architectures and Technologies

2.1 Links, Thruput/Buffering, Multi-Access Ovrhds
2.2 Memories: On-chip / Off-chip SRAM, DRAM
2.A Appendix: Elastic Buffers for Cross-Clock Commun.

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2.2 Memories: On-chip / Off-chip SRAM, DRAM

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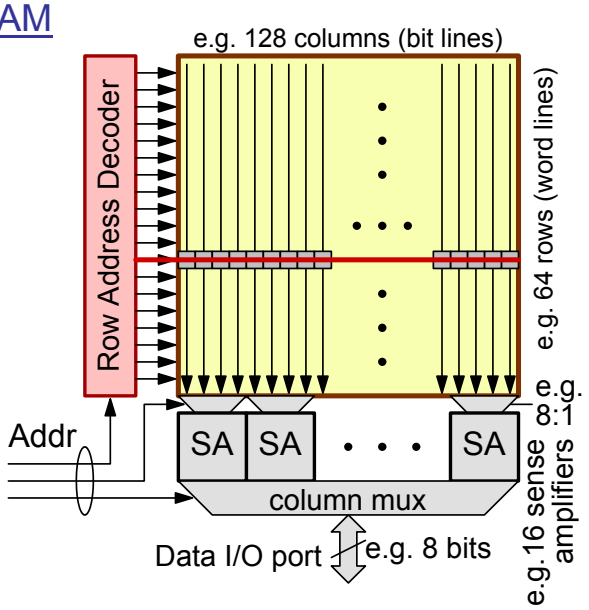
2.2.1 On-Chip SRAM

Read Cycle Includes:

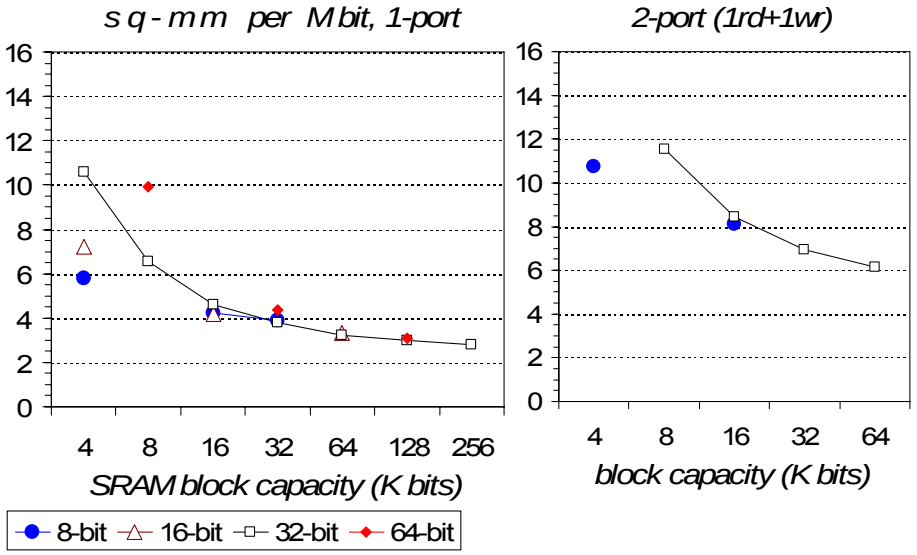
- Precharge bit lines
- Decode row address
- Activate word line
  - faster when narrow
- Discharge bit lines
  - faster when short
- Sense amplifiers
  - don't wait for full discharge before telling the result
- Column multiplexors
  - use column address



Sense Amplifiers: Role, Consequences

- Sense amplifiers significantly speed up read access time
  - sense 0-contents soon after bit-line discharge has started
- Sense amplifiers (SA) are large in size
  - can fit only one SA per 4 or 8 (typically) columns
  - analog multiplexors before SA select columns to be read
  - digital multiplexors after SA for narrow port widths
- Sense amplifiers consume significant energy when activated
  - only activate the block when read data are actually needed
  - power consumption is proportional to access frequency
  - power consumption is proportional to number of sense amp's (increases with port width, or with bit capacity of SRAM)

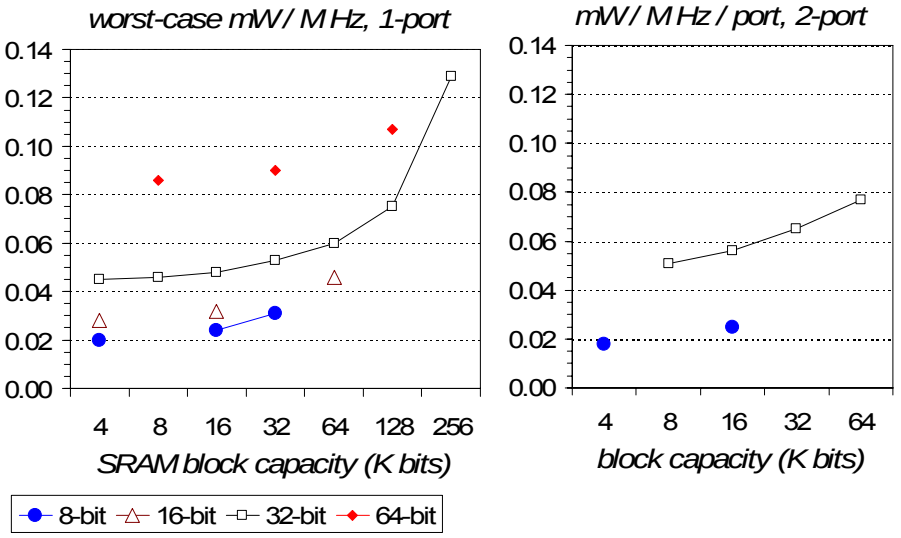
Example on-chip SRAM blocks (130nm CMOS): **Area**



Area per (Kilo/Mega-) bit: Comments

- Older generation (~2005); values are $(\mu m)^2$/bit = $(mm)^2$/Mbit
- Area efficiency increases with block capacity
  - peripheral overhead (address decoders, column multiplexors, sense amplifiers) grows slower than core
- Port width costs a lot for small memories
  - more sense amplifiers, possibly non-square aspect ratio
  - (large memories may already have more SA's than port width)
- 1 sense amplifier per 8 columns, usually
- Two-port area ≈ 2 × one-port area
- Power ring is *not* included in the quoted area figures
  - add 25 µm on each side of the block that is given in the above chart: width and heigth increase by 50 µn each
- Quoted blocks have per-Byte write-enable signals

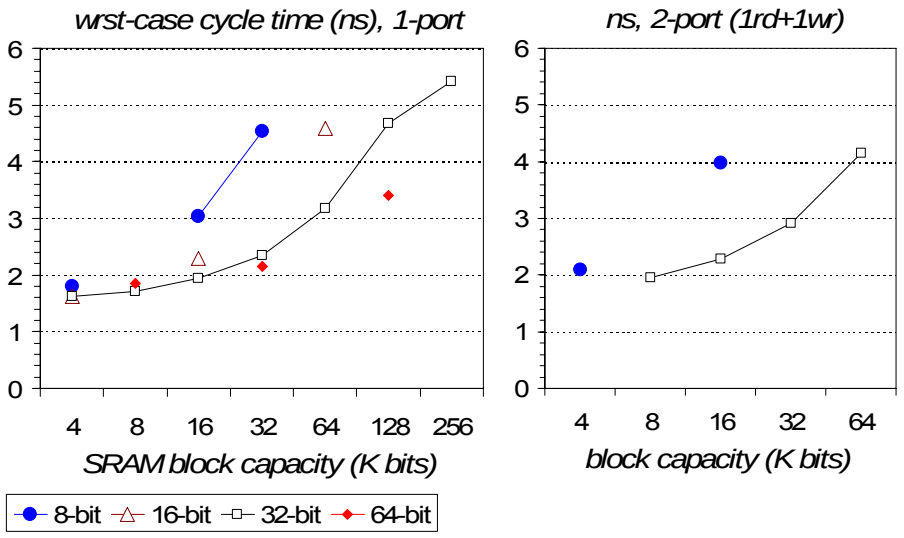
Ex. on-chip SRAM (130 nm): **Power Consumption**



Power Consumption (mW/MHz): Comments

- Slightly old generation (~2005): 130 nm
- Worst-case consumption quoted; V_{DD} = 1.2 Volts
- Consumption is proportional to access frequency: *mW / MHz*
- Consumption is dominated by port-width, esp. for small blocks
  - actually by the number of SA's –may be larger than needed, for narrow-port memories
- Consumption increases with block size due to increasing word-line and bit-line capacitance
  - also increases when size is such that it requires more SA's
- Two-port memory consumption is *per-port*
- Two-port total consumption ≈ 2 × one-port consumption

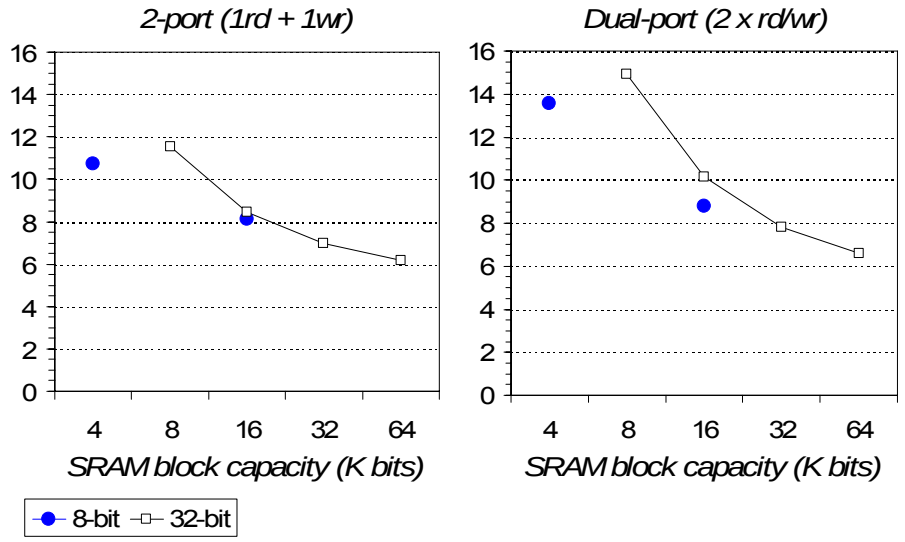
Ex. on-chip SRAM (130nm): **Access Cycle Time**



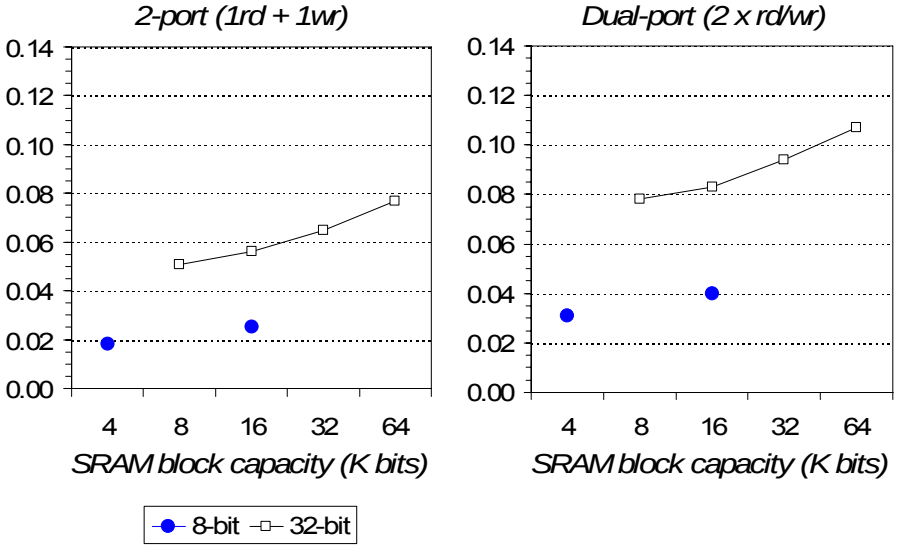
Cycle Time (1/AccessRate): Comments

- Slightly old generation (~2005): 130 nm
- Worst-case cycle-time quoted; V_{DD} = 1.2 Volts
  - Blocks compiled for performance
- Large SRAM's are slower than small SRAM's (small is fast)
  - bit-line (and word-line) capacitance increases with length
  - beyond the "knee" of the curve, it is advantageous to use smaller SRAM's + external data mux than to use single large SRAM (tree of read-multiplexors becomes faster than single large mux)
- For large blocks, narrow ports increase the read latency, due to extra multiplexors after the sense amplifiers
  - looks like this also increases the cycle time
- Two-port speed ≈ speed of 1-port block with 2 × num. of bits

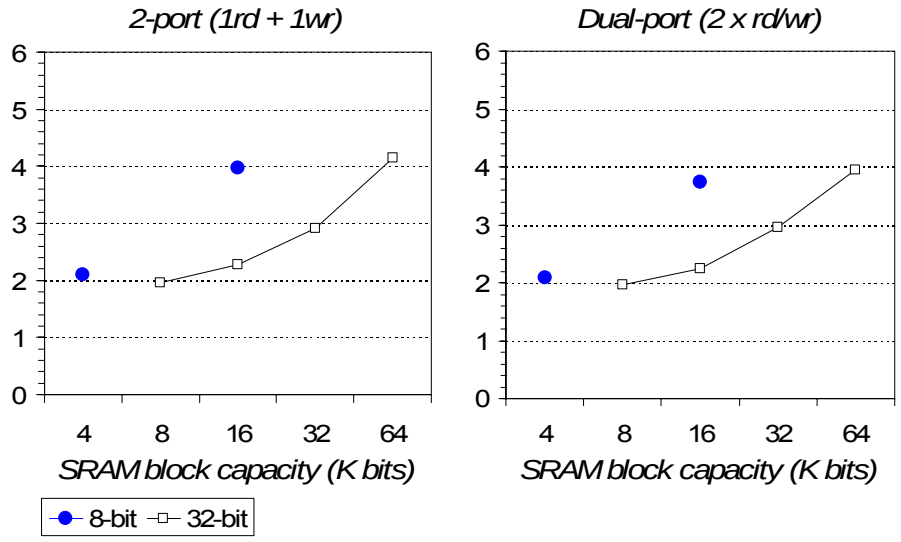
2-Port versus Dual-Port Area (square-mm / Mbit)



2-Port vs. Dual-Port Power (worst-case mW / MHz)



2-Port versus Dual-Port Cycle Time (ns, worst-case)



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On-Chip SRAM Buffer Example 1 of 2: 40-Byte wide

- Width = 1 min-size IP packet = 40 Bytes = 320 bits =
  = 5 blocks × 64 bits/block
- One-Port, 2048 packets × 40 B/pck = 80 KB = 640 Kb
- 130 nm CMOS, 1.2 Volts
- Area = 5 banks × 128 Kb/bank × 3 mm^2/Mb =
  = 0.64 Mb × 3 mm^2/Mb ≈ **2 mm^2**
- Throughput = 320 bits × 300 Maccesses/s ≈ **100 Gb/s**
- Power Consumption =
  = 5 banks × 0.11 mW/MHz × 300 MHz = **165 mW**

On-Chip SRAM Buffer Example 2 of 2: 256-Byte wide

- Width ≈ 1 average-size IP packet = 256 Bytes = 2048 bits =
  = 64 blocks × 32 bits/block
- Two-Port (1rd+1wr), 2048 packets × 256 B = 512 KB = 4 Mb
- 130 nm CMOS, 1.2 Volts
- Area = 64 banks × 64 Kb/bank × 6.1 mm^2/Mb =
  = 4 Mb × 6.1 mm^2/Mb ≈ **25 mm^2**
- Throughput = 2 ports × 2048 b/port × 240 MHz ≈ **1 Tb/s**
  (500 Gb/s writes + 500 Gb/s reads)
- Power Consumption =
  = 64 banks × 2 ports × 0.08 mW/MHz × 240 MHz ≈ **2.4 W**
- **Conclusion:** "no problem" on-chip, except for short packets

Power Cons./Throughput (1 of 2): on-chip **SRAM**

- Consider some "usual, medium-size" SRAM blocks (130 nm):
  - 1-port, ×16: ≈ 0.03 mW/MHz = 0.03 mW / 16 Mbps ≈ 2.0 mW/Gbps
  - 1-port, ×32: ≈ 0.05 mW/MHz = 0.05 mW / 32 Mbps ≈ 1.6 mW/Gbps
  - 1-port, ×64: ≈ 0.10 mW/MHz = 0.10 mW / 64 Mbps ≈ 1.6 mW/Gbps
  - 2-port, ×8: ≈ 0.02 mW/MHz = 0.02 mW / 8 Mbps ≈ 2.5 mW/Gbps
  - 2-port, ×32: ≈ 0.06 mW/MHz = 0.06 mW / 32 Mbps ≈ 2.0 mW/Gbps

- Conclusion: **1.5 to 2.0 mW/GBps** power consumption for on-chip buffer memories

Power Cons./Throughput (2 of 2): **Chip I/O**

- High-speed serial off-chip transceiver ≈ **10 to 25 mW/Gbps**
  - e.g. differential pair, 3.125 Gbaud (8b/10b encoding) = 2.5 Gb/s
  - 130 nm CMOS, both transmitter and receiver power considered
  - assume no pre-emphasis at the transmitter for line equalization purposes – such pre-emphasis would consume considerably
  - copper cable consumption is very small, compared to others

⇒ **Conclusion:** chip-to-chip communication costs *an order of magnitude more* than on-chip buffering, in term of power cons.

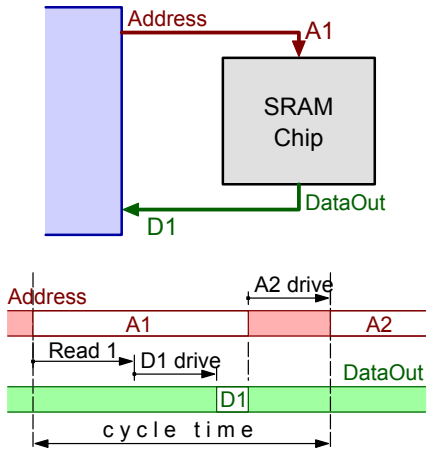
- Total chip power consumption (limited to ≈ 10 to 30 Watts) limits total chip throughput to *about 1 Tbps/chip* or less

2.2.2 Off-Chip SRAM Technologies

- Large on-chip throughput, owing to parallelism of accesses
- Gradual improvements in pin-interface protocols (late 90's):

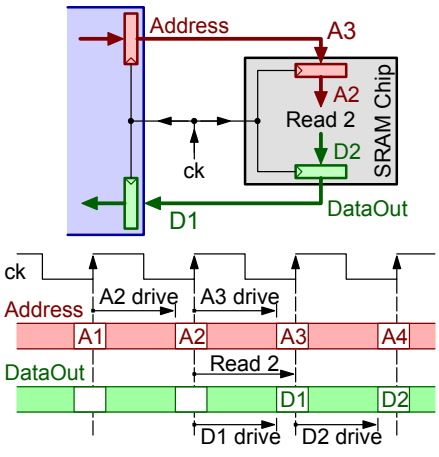
1. Clock-synchronous, pipelined address/data communication
2. Double-Data Rate (DDR) data-pin timing (see §2.1)
3. Source-synchronous clocking
   - clock signal propagating in the same direction as data (or address) signals – normally implies two separate clocks
4. Separate, unidirectional Write-Data and Read-Data buses
   - avoids bus turn-around overhead, but
   - requires 50% writes – 50% reads for full utilization
5. Write-data timing similar to read-data timing
   - first send the address, later send the data, so that address-bus to data-bus time-offset stays fixed for reads & writes

Clock-Synchronous RAM: Pipelined Communication



"Flow Through": old timing

- no overlapping between SRAM operation and communication



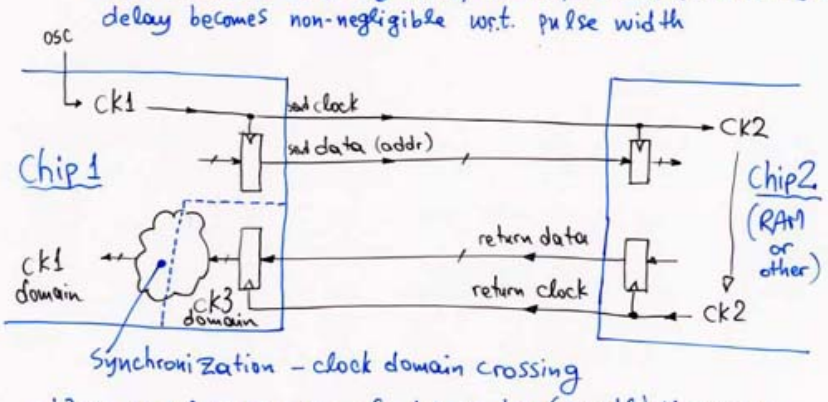
"Synchronous" Registered Interface

- pipelined SRAM operation and chip-to-chip communication

... further increasing the data pin throughput of chip-to-chip communication...

(3) Source-Synchronous Data Clocking

when the clock frequency rises, the chip-to-chip (speed-of-light) delay becomes non-negligible w.r.t. pulse width



ck3 is a delayed version of ck1, i.e. has (exactly) the same frequency, but its delay (phase shift) may vary (slowly) with time...

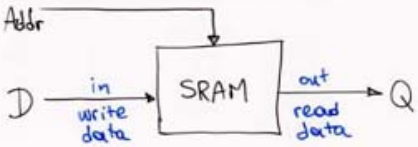
SRAM Data I/O Paths:

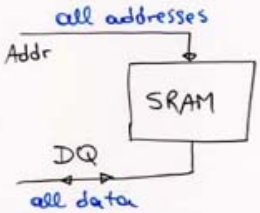
Separate D (in) and Q (out) Paths:

versus

Shared "DQ" Data Bus:

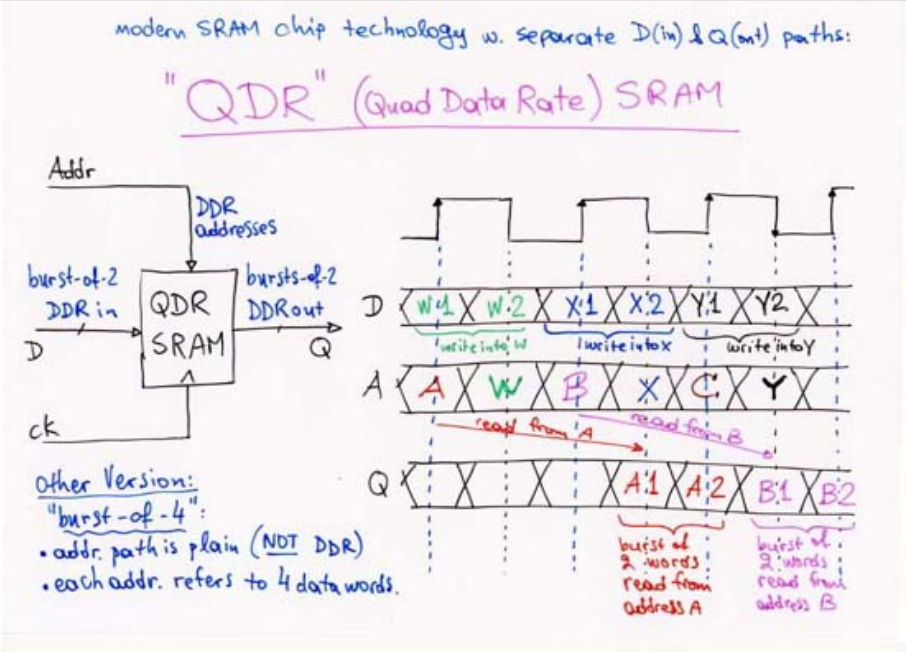
time-mux'ed write & read addresses





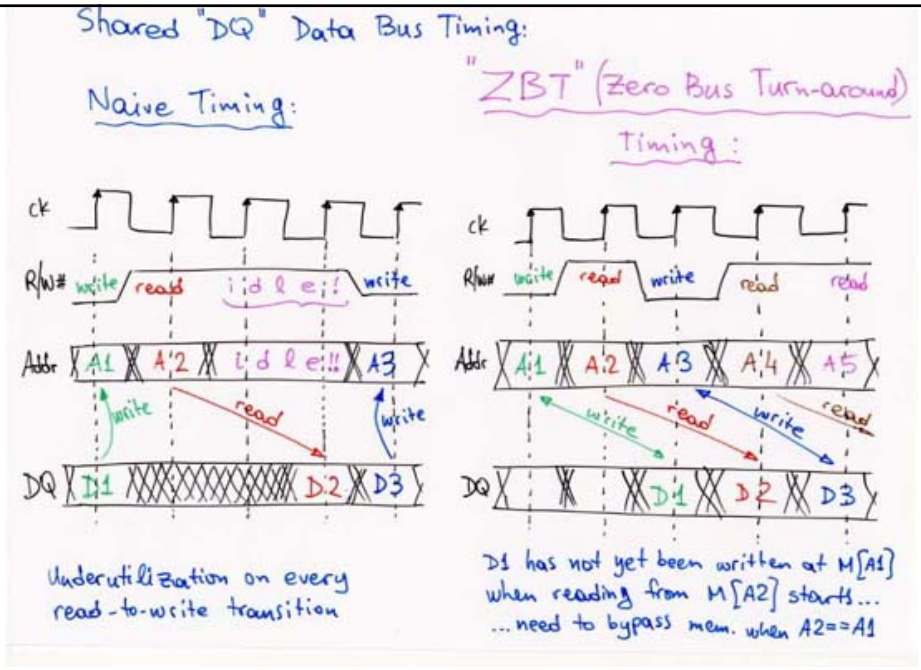
⊖: data path underutilization when inbalanced (≠ 50% - 50%) read/write transactions

⊖: bus turn-around overhead: data bus underutilization when frequently switching between read & write transactions



Example QDR SRAM (2007): CY7C1545V18

- 72 Mbits = 4 M × 18 bits (width = 2 Bytes + parity/ECC)
- ≤ 375 MHz clock ⇒ cycle = 2.67 ns; bit-time = 1.33ns (DDR)
- Burst-of-4 words ↔ simple (non-DDR) address timing
- Peak Write Throughput:
  375 MHz × 2 (DDR) × 16 bits = 12 Gb/s/chip = 1.5 GB/s
- Peak Read Throughput = (similarly) 12 Gb/s
- Peak Total throughput *for balanced (50%-50%)* read-write:
  12 + 12 = 24 Gb/s = 3 GB/s
- Power consumption ≈ 2.4 W (typical) @ 375 MHz, 1.8 Volt
  ⇒ Power per throughput ≈ 2.4 W / 24 Gbps ≈ 100 mW/Gbps



Example Shared-Bus SRAM (2007): CY7C1550V18

- 72 Mbits = 2 M × 36 bits (width = 4 Bytes + parity/ECC)
- ≤ 375 MHz clock ⇒ cycle = 2.67 ns; bit-time = 1.33ns (DDR)
- Peak Throughput = 375 MHz × 2 (DDR) × 32 bits = 24 Gb/s
- "NoBL" (No Bus Latency) = "ZBT" (Zero Bus Turn-Around, ala Micron)
- Although NoBL/ZBT, one clock cycle is lost every time the bus direction changes from read to write (bus turn-around)

  ⇒ throughput with alternating read/writes ≈
  ≈ 2/3 × peak throughput ≈ 16 Gb/s
- Power consumption ≈ 2.4 W (typical) @ 375 MHz, 1.8 Volts

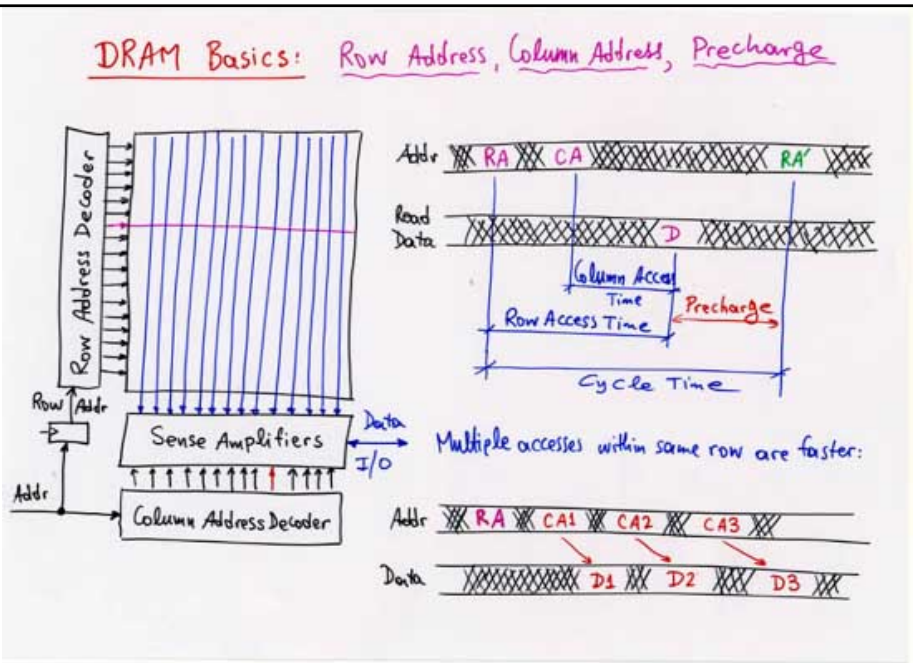
  ⇒ Power per throughput ≈ 2.4 W / 24 Gbps ≈ 100 mW/Gbps

2.2.3 Dynamic RAM Chips and their Pin Interface

- Highest density and longest internal latency RAM chips
- Huge internal parallelism, when addresses are *favorable:*
  - multiple banks – memory interleaving
  - per-bank: entire *row* (hundreds of bits) accessed in parallel
- Pin Interface: advanced techniques to increase throughput
  - pins synchronized to a high-speed clock (Synchronous DRAM)
  - 100's of bits piped thru 10's of data pins during several clocks
  - internal RAM access is independent of clock – multiple cycles
- Three-step internal accesses – each bank independently
  - *row access:* activate a row in a bank, copy into sense amp's
  - *column access:* read/write multiple bits in selected row
  - *precharge:* get this bank ready for activating another row
- Address pins time-shared: row – column addr; multiple banks

Example DDR3 SDRAM (2007): MT41J64M16

- 1 Gbit = 64 M × 16 bits = 8 banks × 8 Mw/bank × 16 b/w
- ≤ 800 MHz clock
- Bidirectional data pins, DDR timing ⇒ up to 1.6 Gbps/pin
- Internal latencies specified as absolute times:
  - row-addr. to column-addr. ≥ 14 ns
  - column-addr. to read-data ≥ 14 ns
  - bank-cycle time ≥ 48 ns; precharge time ≥ 14 ns
- Translated to # of clock cycles by user @ boot time
  - e.g. at 800 MHz: row-acc ≥ 11~, col-acc ≥ 11~, bnk-cycle ≥ 38~
- (Remaining slides are for a much older chip (~2001)…)



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Fast DRAM Example (2001)

Micron MT46 V2 M32

DDR SDRAM

(Synchronous DRAM)

- 200 MHz max. clock frequency
- 64 Mbits = 2M x 32 bits = = 512K x 32b x 4 Banks
- 32-bit (shared DQ) databus, DDR timing ⇒ ⇒ 2 words x 32 bits each per clock cycle peak databus throughput
- ≈ 1 Watt at peak access rate, using one bank only, 2.5 Volt. (No number given for multibank op.)
- Row Address-to-Column Address: ..... $t_{RCD} \geq 20ns$ (@200MHz: 4~)
- Column Address-to-Read Data (CAS latency): ... $CL \geq 15ns$ (@200MHz: 3~)
- Write Recovery Time (write data-to-precharge): ... $t_{WR} \geq$ ..... 2~
- Precharge Time: ..... $t_{RP} \geq 20ns$ (@200MHz: 4~)
- Cycle Time (same bank): ..... $t_{RC} \geq 60ns$ (@200MHz: 12~)
- Bank-to-Bank Activation (other bank Row-to-Row): t_{RRD} ..... 2~
- Read-to-Write bus turn-around lost cycles: ..... 3~
- Write-to-Read same bank lost cycles (write recovery time): ..... 2~
- Write-to-Read other bank lost cycles: ..... Ø~

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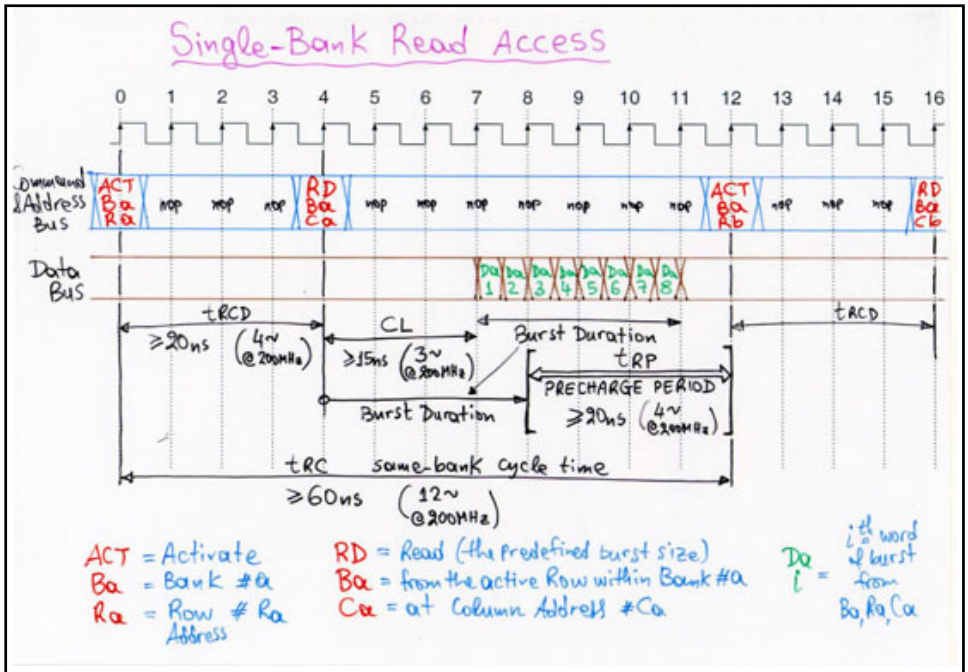
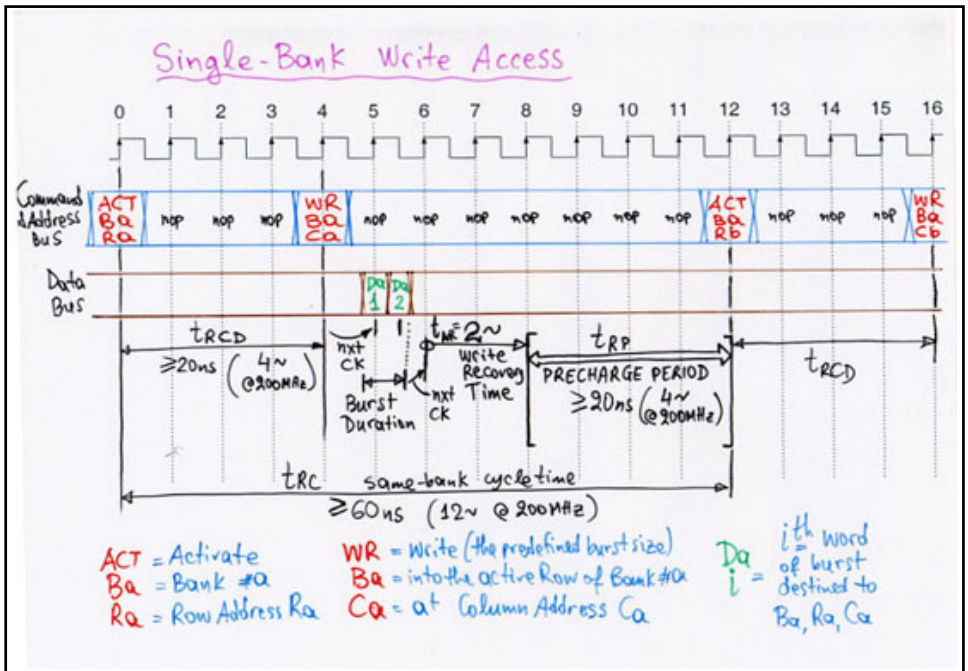
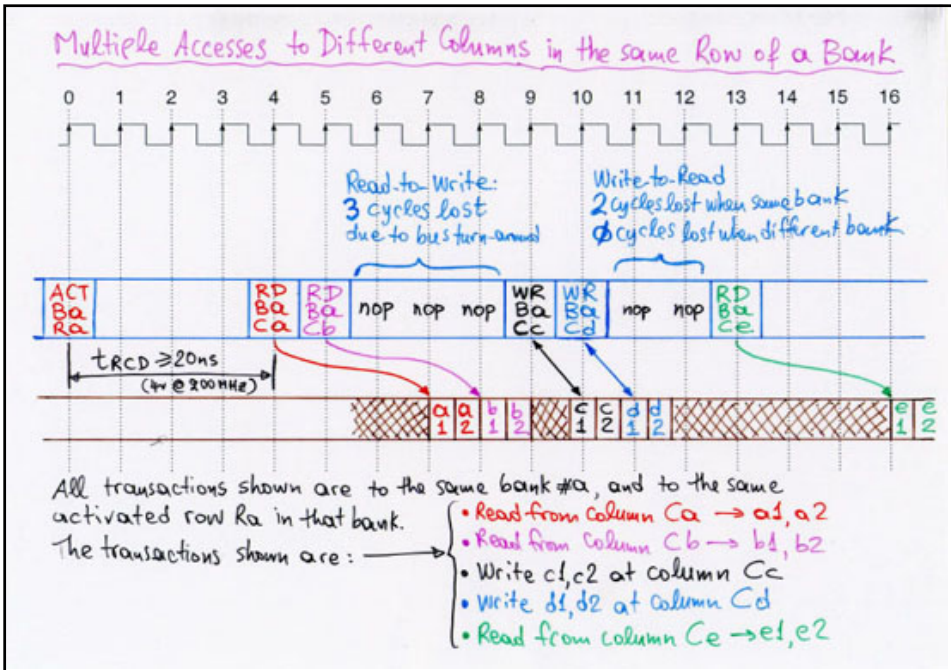
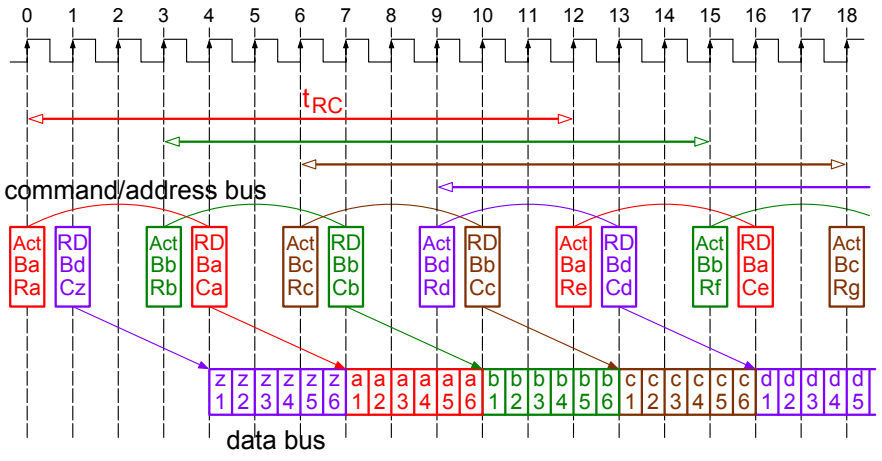

Single-Bank Read Access
0 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16
Command & Address Bus
ACT Ba Ra
RD Ba Ca
ACT Ba Rb
RD Ba Cb
nop
Data Bus
Da 1 Da 2 Da 3 Da 4 Da 5 Da 6 Da 7 Da 8
tRCD
≥20ns (4~ @200MHz)
CL
≥15ns (3~ @200MHz)
Burst Duration
tRP
PRECHARGE PERIOD
≥20ns (4~ @200MHz)
tRCD
tRC same-bank cycle time
≥60ns (12~ @200MHz)
ACT = Activate
Ba = Bank #a
Ra = Row # Ra Address
RD = Read (the predefined burst size)
Ba = from the active Row within Bank #a
Ca = at Column Address #Ca
Da i = i-th word of burst from Ba, Ra, Ca


Single-Bank Write Access
0 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16
Command & Address Bus
ACT Ba Ra
WR Ba Ca
ACT Ba Rb
WR Ba Cb
nop
Data Bus
Da 1 Da 2
tRCD
≥20ns (4~ @200MHz)
nxt CK
Burst Duration
nxt CK
tWR = 2~
Write Recovery Time
tRP
PRECHARGE PERIOD
≥20ns (4~ @200MHz)
tRCD
tRC same-bank cycle time
≥60ns (12~ @200MHz)
ACT = Activate
Ba = Bank #a
Ra = Row Address Ra
WR = Write (the predefined burst size)
Ba = into the active Row of Bank #a
Ca = at Column Address Ca
Da i = i-th word of burst destined to Ba, Ra, Ca



Multi-Bank Operation: Memory Interleavin



- burst length set to 8; each successive READ command interrupts the preceding burst, resulting in net bursts of 6.